

 Report No.: 18220WC30049301
 FCC ID: 2ALU5G402TX
 Page 1 of 84

FCC SAR Test Report

Client Name : TeVii Technology Co.,Ltd.

Address

10F, No. 125, Sec. 2, Datong Rd. 22183 Xizhi District, New Taipei City, Taiwan

Product Name : 4K HDMI Extender Wireless Transmitter

Date

Oct. 27, 2023



Shenzhen Anbotek Compliance Laboratory Limited

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 2 of 84 Contents

1. Statement of Compliance		unbotek	Anbor	and tek	6
 Statement of Compliance General Information 	Ano		Anbor		7
2.1 Client Information 2.2 Description of Equipment Under Tes	Anbo		polote.	Anu	»7°
2.2 Description of Equipment Under Tes	t (EUT)	Ann	K	Anbo	7
2.3 Device Category and SAR Limits	ok	ter Anb		ek Ant	9
2.4 Applied Standard		notek Anb	o. P.		
2.5 Environment of Test Site 2.6 Test Configuration	00. Pr.	wotek	nbote. An		9
2.6 Test Configuration	Aupore	An	Lubotek	Anbu	9
2.7 Description of Test Facility	Anboten	And	tek.	Anbor	10
Specific Absorption Rate (SAR)	LO ^{ter}	Ano	-to-		
3.1 Introduction 3.2 SAR Definition		ek pobote	Anu	a,,,,	
3.2 SAR Definition	Pur	a,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	otek Anbu		
4. SAR Measurement System	oten An		na ^{Asto}	jor P	12
4.1 E-Field Probe 4.2 Data Acquisition Electronics (DAE)		Anbo, P		upboter.	13
4.2 Data Acquisition Electronics (DAE)		pobole	Anu	Anbotek	13
4.3 Robot 4.4 Measurement Server	Marrie Marrie	Kupoten.	Anbu		14
4.4 Measurement Server	Anbe		Anbore	Pres	
4.5 Phantom	anb.	- C	tothe store	Pu.	
4.6 Device Holder		<u> </u>		0 · · · · · · · · · · · · · · · · · · ·	
4.7 Data Storage and Evaluation		mboten Al	100 10		
5. Test Equipment List	inp.				20
 6. Tissue Simulating Liquids 7. System Verification Procedures 	Anbor	P	huboten	Anu	21
7. System Verification Procedures	pabote	Anu	. tootok	Anbo	22
8. EUT Testing Position	k hote	Anbe	tel atel	s nbo	
9. Measurement Procedures		24			
9.1 Spatial Peak SAR Evaluation		worket wo	poten Ant		25
9.2 Power Reference Measurement	obote. P		Antorek	nbo.	
9.3 Area Scan Procedures	Anboten	Anbu		pabore	
9.4 Zoom Scan Procedures 9.5 Volume Scan Procedures		Aupor	An. March	Anboten	27
9.5 Volume Scan Procedures		haboten	And		28
9.6 Power Drift Monitoring	Anu		ak Anbo.		
10. Conducted Power	rek Anbo		otek pobo	re. An	29
11. Antenna Location	wate ^k	hour Nu		poter	
12. SAR Test Results Summary		popoter	Ann		
13. Simultaneous Transmission Analysis	Ann	httpotek	Anbo	hotek	35
Simultaneous TX SAR Considerations	Anbo.		pobote.	Ann	
 9.5 Volume Scan Procedures 9.6 Power Drift Monitoring 10. Conducted Power 11. Antenna Location	Anbore	An	K. Krbotek	Anbo	36
Appendix A. EUT Photos and Test Setup Pl	hotos	en Anbu		ek prit	

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Report No.: 18220WC30049301	FCC ID: 2ALU5G402TX	Page 3 o	f 84 🔊
Appendix B. Plots of SAR System Check	h hat hat hat hat hat hat hat hat hat ha	Jose Mun	
Appendix C. Plots of SAR Test Data	atek pubote Ann Mak	hotek Anbo	41
Appendix D. DASY System Calibration Certifi	icate	Mator Mator	45

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 4 of 84

TEST REPORT

Applicant	: TeVii Technology Co.,Ltd.
Manufacturer	: TeVii Technology Co.,Ltd.
Product Name	: 4K HDMI Extender Wireless Transmitter
Model No.	: G402 TX, Present+Share Mini 4K Edition
Trade Mark	: TEVII, ClearClick
Rating(s)	: Input: 5V 1A

Test Standard(s)

IEC/IEEE 62209-1528:2020; FCC 47 CFR Part 2.1093; ANSI/IEEE C95.1:2005; Reference FCC KDB 447498; KDB 248227; KDB 616217

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the IEC/IEEE 62209-1528:2020, FCC 47 CFR Part 2.1093, ANSI/IEEE C95.1:2005 and Reference KDB 447498, KDB 248227, KDB 616217 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt Date of Test Mar. 27, 2023 Apr. 05 - 07, 2023

Isian

Prepared By

(Ella Liang)

Ella

Idward pan

(Edward Pan)

Approved & Authorized Signer

Shenzhen Anbotek Compliance Laboratory Limited

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 5 of 84 Version

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Code:AB-RF-05-b



Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 6 of 84

1. Statement of Compliance

The maximum results of Specific Absorption Rate (SAR) found during testing are as follows.

<Highest SAR Summary>

Eregueney Bond	Highe	est Reported 1g-SAR(W	//Kg)	SAR Test Limi	it
Frequency Band	Body-worn(0mm)			(W/Kg)	
WIFI 5.2G ANT1	K Anbort	0.379	Ano	abotek Anb	0,
WIFI 5.2G ANT2	otek Anboten	0.347	Anbo	pin abotek p	nbr
WIFI 5.8G ANT1	hotek Anboter	0.418	stek Anboi	1.6	
WIFI 5.8G ANT2	me stek anbo	0.444	botek Anbot	Anthotek	6
Simultaneous	And	0.862	botek Ant	poten Anbo	1-
Test Result	Anbo	PASS	Ann	Anbotek Anbo	e¥

This device is in compliance with Specific Absorption Rate (SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in KDB 447498 D01 v06, 2015 and ANSI/IEEE C95.1:2005, and had been tested in accordance with the measurement methods and procedures specified in IEEE 1528-2013.

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 7 of 84

2. General Information

2.1 Client Information

Applicant	:	TeVii Technology Co.,Ltd.
Address	:	10F, No. 125, Sec. 2, Datong Rd. 22183 Xizhi District, New Taipei City, Taiwan
Manufacturer	:	TeVii Technology Co.,Ltd.
Address	:	10F, No. 125, Sec. 2, Datong Rd. 22183 Xizhi District, New Taipei City, Taiwan
Factory	:	TeVii Technology Co.,Ltd.
Address	:	10F, No. 125, Sec. 2, Datong Rd. 22183 Xizhi District, New Taipei City, Taiwan

2.2 Description of Equipment Under Test (EUT)

e	Product Name	•	4K HDMI Extender Wireless Transmitter					
P	Model No.	:	(Note: All samples are	G402 TX, Present+Share Mini 4K Edition (Note: All samples are the same except the model number, Logo and appearance, so we prepare "G402 TX" for test only.)				
	Trade Mark	:	TEVII, ClearClick	Anborek Anborek Anborek Anborek				
×	Test Power Supply	:	DC 5V	oten Anbotek Anbotek Anbotek Anbotek				
20	Test Sample No.	:	1-2-2(Engineering San	1-2-2(Engineering Sample)				
Product Description	:	Operation Frequency: Number of Channel:	WiFi 5.2G: 5180~5240MHz WiFi 5.8G: 5745~5825MHz WiFi 5.2G: 4 Channels for 802.11a/n(HT20)/ac(HT20) 2 Channels for 802.11n(HT40)/ac(HT40) 1 Channel for 802.11ac(HT80) WiFi 5.8G: 5 Channels for 802.11a/n(HT20)/ac(HT20) 2 Channels for 802.11a(HT40)/ac(HT40) 1 Channel for 802.11ac(HT80)					
-			Modulation Type:	WiFi 5G: OFDM with BPSK, QPSK, 16QAM, 64QAM, 256QAM				
ul De			Antenna Type:	ANT1: FPC Antenna ANT2: PCB Antenna				

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Report No.: 18220WC30049301	FCC ID: 2ALU5G402TX	Page 8 of 84
Ann otek Unbotek	Wi-Fi 5.2G ANT1: 3.05dBi	Anboro An
Antonno Opin (De all)	Wi-Fi 5.2G ANT2: 2.5dBi	Anboten Anbo
Antenna Gain(Peak):	Wi-Fi 5.8G ANT1: 2.65dBi	abotek Anbort
ek Anboten An	Wi-Fi 5.8G ANT2: 2.6dBi	k hotek Anboten

Remark:

1) All of the RF specification are provided by customer.

2) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 9 of 84

2.3 Device Category and SAR Limits

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

2.4 Applied Standard

The Specific Absorption Rate (SAR) testing specification, method, and procedure for this device is in accordance with the following standards:

IEC/IEEE 62209-1528:2020

ANSI/IEEE C95.1:2005

FCC 47 CFR Part 2.1093

Reference FCC KDB 447498; KDB 248227; KDB 616217

2.5 Environment of Test Site

Items	Required	Actual
Temperature (°C)	18-25	22~23
Humidity (%RH)	30-70	55~65 ⁰⁰⁰

2.6 Test Configuration

For WIFI and Bluetooth SAR testing, engineering testing software installed on the EUT can provide continuous transmitting RF signal.

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 10 of 84

2.7 Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111.

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

Test Location

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Code:AB-RF-05-b





Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 11 of 84

3. Specific Absorption Rate (SAR)

3.1 Introduction

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits higher limits general than the for are population/uncontrolled.

3.2 SAR Definition

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ).The equation description is as below:

$$SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho dv} \right)$$

SAR is expressed in units of Watts per kilogram (W/kg)

SAR measurement can be either related to the temperature elevation in tissue by

$$SAR = C\left(\frac{\delta T}{\delta t}\right)$$

Where: C is the specific head capacity, δT is the temperature rise and δ tisthe exposure duration, or related to the electrical field in the tissue by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

Where: σ is the conductivity of the tissue, ρ is the mass density of the tissue and E is the RMS electrical field strength.

However for evaluating SAR of low power transmitter, electrical field measurement is typically applied.

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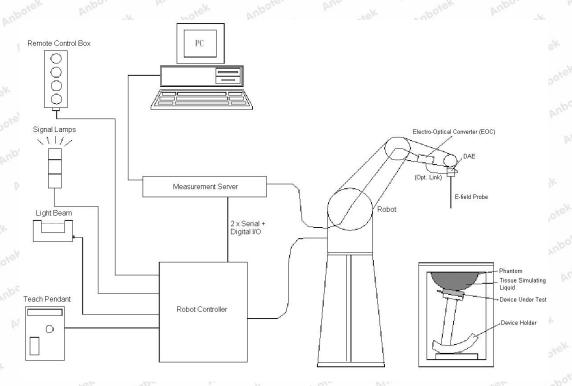






Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 12 of 84

4. SAR Measurement System



DASY System Configurations

The DASY system for performance compliance tests is illustrated above graphically. This system consists of the following items:

- > A standard high precision 6-axis robot with controller, a teach pendant and software
- A data acquisition electronic (DAE) attached to the robot arm extension
- A dosimetric probe equipped with an optical surface detector system
- The electro-optical converter (EOC) performs the conversion between optical and electrical signals
- A measurement server performs the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- A probe alignment unit which improves the accuracy of the probe positioning
- A computer operating Windows XP
- DASY software
- Remove control with teach pendant and additional circuitry for robot safety such as warming lamps, etc.
- The SAM twin phantom
- A device holder

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Code:AB-RF-05-b



Report No.: 18220WC30049301

FCC ID: 2ALU5G402TX Page 13 of 84

Tissue simulating liquid

> Dipole for evaluating the proper functioning of the system

components are described in details in the following sub-sections.

4.1 E-Field Probe

The SAR measurement is conducted with the dosimetric probe (manufactured by SPEAG). The probe is specially designed and calibrated for use in liquid with high permittivity. The dosimetric probe has special calibration in liquid at different frequency. This probe has a built in optical surface detection system to prevent from collision with phantom.

<ex3dv4 prob<="" th=""><th>er stek hibo, hi set spote</th><th>Ann</th></ex3dv4>	er stek hibo, hi set spote	Ann
Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)	7
Frequency	10 MHz to 6 GHz; Linearity: ± 0.2 dB	5.3
Directivity	 ± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis) 	
Dynamic Range	10 μW/g to 100 mW/g; Linearity: ± 0.2 dB (noise: typically < 1 μW/g)	
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm	oto of EX3DV4

E-Field Probe Specification <EX3DV4 Probe>

E-Field Probe Calibration

Each probe needs to be calibrated according to a dosimetric assessment procedure with accuracy better than \pm 10%. The spherical isotropy shall be evaluated and within \pm 0.25dB. The sensitivity parameters (NormX, NormY, and NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested. The calibration data can be referred to appendix C of this report.

4.2 Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

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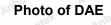
Hotline

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Report No.: 18220WC30049301FCC ID: 2ALU5G402TXPage 14 of 84The input impedance of the DAE is 200MOhm; the inputs are symmetrical and floating. Common
mode rejection is above 80dB.FCC ID: 2ALU5G402TXPage 14 of 84





4.3 Robot

The SPEAG DASY system uses the high precision robots (DASY5: TX60XL) type from Stäubli SA (France). For the 6-axis controller system, the robot controller version (DASY5: CS8c) from Stäubli is used. The Stäubli robot series have many features that are important for our application:

- > High precision (repeatability ±0.035 mm)
- High reliability (industrial design)
- Jerk-free straight movements
- > Low ELF interference (the closed metallic construction shields against motor control fields)



Photo of DASY5

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 15 of 84

4.4 Measurement Server

The measurement server is based on a PC/104 CPU board with CPU (DASY5: 400 MHz, Intel Celeron), chip disk (DASY5: 128 MB), RAM (DASY5: 128 MB). The necessary circuits for communication with the DAE electronic box, as well as the 16 bit AD converter system for optical detection and digital I/O interface are contained on the DASY I/O board, which is directly connected to the PC/104 bus of the CPU board.

The measurement server performs all the real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operations.



Photo of Server for DASY5

4.5 Phantom

<SAM Twin Phantom>

Shell Thickness	2 ± 0.2 mm;	indo ek
	Center ear point: 6 ± 0.2 mm	P
Filling Volume	Approx. 25 liters	01,74
Dimensions	Length: 1000 mm; Width: 500 mm; Height: adjustable feet	
Measurement	Left Hand, Right Hand, Flat	
Areas	Phantom	A ^r
	hotek Anbo. A. stek	NOPO PARA

Photo of SAM Phantom

The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections. A white cover is provided to tap the phantom during off-periods to prevent water evaporation and changes in the liquid parameters. On the phantom top, three reference markers are provided to identify the phantom position with respect to the robot.

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 16 of 84 <ELI4 Phantom>

10	ANY NOT AT ANY
Shell Thickness	2 ± 0.2 mm (sagging: <1%)
Filling Volume	Approx. 30 liters
Dimensions	Major ellipse axis: 600 mm
	Minor axis:400 mm
	obotek Anbore All botek Arport
<	hotek Anboter And tek out
	And otek unbotek Anbou ak
	Anbo tak subotek Anbole k soter Anb
	Photo of ELI4 Phantom
	stek anboten Andre ek motek andre erek andr

The ELI4 phantom is intended for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI4 is fully compatible with standard and all known tissue simulating liquids.

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Code:AB-RF-05-b



Report No.: 18220WC30049301

FCC ID: 2ALU5G402TX Page 17 of 84

4.6 Device Holder

The SAR in the phantom is approximately inversely proportional to the square of the distance between the source and the liquid surface. For a source at 5 mm distance, a positioning uncertainty of ± 0.5 mm would produce a SAR uncertainty of $\pm 20\%$. Accurate device positioning is therefore crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards.

The DASY device holder is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear reference points). The rotation center for both scales is the ear reference point (ERP). Thus the device needs no repositioning when changing the angles.

The DASY device holder is constructed of low-loss POM material having the following dielectric parameters: relative permittivity ε = 3 and loss tangent δ = 0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.





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Report No.: 18220WC30049301

FCC ID: 2ALU5G402TX Page 18 of 84

4.7 Data Storage and Evaluation

Data Storage

The DASY software stores the assessed data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all the necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files. The post-processing software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of erroneous parameter settings. For example, if a measurement has been performed with an incorrect crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be reevaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type (e.g., [V/m], [A/m], [mW/g]). Some of these units are not available in certain situations or give meaningless results, e.g., a SAR-output in a non-lose media, will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

Data Evaluation

The DASY post-processing software (SEMCAD) automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Norm _i , a _{i0} , a _{i1} , a _{i2}
	- Conversion factor	ConvFi
	- Diode compression point	t dcpi
Device parameters	:- Frequency	kf Anborek Anbor
	- Crest factor	cf hotek Anb
Media parameters:	- Conductivity	σ Ant sotek
	- Density	poten Anbo

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY components. In the direct measuring mode of the multi-meter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to

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Code:AB-RF-05-b



Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 19 of 84 correctly compensate for peak power. Page 19 of 84

The formula for each channel can be given as:

$$\mathbf{V_i} = \mathbf{U_i} + \mathbf{U_i^2} \cdot \frac{\mathbf{cf}}{\mathbf{dcp}}$$

with V_i= compensated signal of channel i, (i = x, y, z)

 U_i = input signal of channel i, (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals, the primary field data for each channel can be evaluated:

E-field Probes: $E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$

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H-field Probes: $H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$

with V_i = compensated signal of channel i, (i = x, y, z) Norm_i= sensor sensitivity of channel i, (i = x, y, z), $\mu V/(V/m)^2$ for E-field Probes ConvF= sensitivity enhancement in solution

 a_{ij} = sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

E_i= electric field strength of channel i in V/m

H_i= magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

$$SAR = E_{tot}^2 \cdot \frac{\sigma}{\rho \cdot 1000}$$

with SAR = local specific absorption rate in mW/g

E_{tot}= total field strength in V/m

 σ = conductivity in [mho/m] or [Siemens/m]

 ρ = equivalent tissue density in g/cm³

Note that the density is set to 1, to account for actual head tissue density rather than the density of the tissue simulating liquid.

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402T Pade 20 ot

5. Test Equipment List

Manufacturan	Name of Faultament	Turne (Mandal	Corrigh Neuropean	Calib	ration	
Manufacturer	Name of Equipment	Type/Model	Serial Number	Last Cal.	Due Date	
SPEAG	5GHz System Validation Kit	D5GHzV2	1160	Oct. 02, 2021	Oct. 01, 2024	
SPEAG	2450MHz System Validation Kit	D2450V2	910	Jun. 15,2021	Jun. 14,2024	
SPEAG	Data Acquisition Electronics	DAE4	387	Sept.06,2022	Sept.05,2023	
SPEAG	Dosimetric E-Field Probe	EX3DV4	7396	May 06,2022	May 05,2023	
Agilent	ENA Series Network Analyzer	E5071C	MY46317418	Oct.26, 2022	Oct.25, 2023	
SPEAG	DAK	DAK-3.5	1226	NCR	NCR	
SPEAG	ELI Phantom	QDOVA004AA	2058	NCR	NCR	
AR	Amplifier	ZHL-42W	QA1118004	NCR	NCR NCR	
Agilent	Power Meter	N1914A	MY50001102	Oct.26, 2022	Oct.25, 2023	
Agilent	Power Sensor	N8481H	MY51240001	Oct.26, 2022	Oct.25, 2023	
R&S	Spectrum Analyzer	N9020A	MY51170037	Oct.26, 2022	Oct.25, 2023	
Agilent	Signal Generation	N5182A	MY48180656	Oct.26, 2022	Oct.25, 2023	
Worken	Directional Coupler	0110A05601O-10	COM5BNW1A2	Oct.26, 2022	Oct.25, 2023	

Note:

1. The calibration certificate of DASY can be referred to appendix C of this report.

The dipole calibration interval can be extended to 3 years with justification. The dipoles are also not 2. physically damaged, or repaired during the interval.

- The Insertion Loss calibration of Dual Directional Coupler and Attenuator were characterized via 3 the network analyzer and compensated during system check.
 - The dielectric probe kit was calibrated via the network analyzer, with the specified procedure (calibrated in pure water) and calibration kit (standard) short circuit, before the dielectric measurement. The specific procedure and calibration kit are provided by Agilent.
- In system check we need to monitor the level on the power meter, and adjust the power amplifier level to have precise power level to the dipole; the measured SAR will be normalized to 1W input power according to the ratio of 1W to the input power to the dipole. For system check, the calibration of the power amplifier is deemed not critically required for correct measurement; the power meter is critical and we do have calibration for it

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402T 'ade

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6. Tissue Simulating Liquids

For the measurement of the field distribution inside the SAM phantom with DASY, the phantom must be filled with around 25 liters of homogeneous body tissue simulating liquid. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm, which is shown in Fig. 6.1. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm, which is shown as followed:



Photo of Liquid Height for Body SAR

The following table gives the recipes for tissue simulating liquid.

Frequency Water		Sugar	Cellulose	Salt	Preventol	DGBE	Conductivity	Permittivity			
(MHz)		(%)	(%)	(%)	(%)	(%)	(%)	(σ)	(ɛr)		
	For Body										
potek	2450	68.6	pote ^V 0	Anbolo	Antonek	31.4	0×nbo	1.95	52.7		
Anbot	5200	78.6	0	10.7	0	4 10.7 mo	0 40	5.27	49.0		
An	5800	78.5	Obotek	10.8	0	10.7	pote ^K 0	6.00	bote ^k 48.2 pro		

The following table shows the measuring results for simulating liquid.

Tiesue	Measured	Target Tissue			Measure	Liquid			
Tissue Type	Frequency (MHz)	٤r	σ	٤r	Dev. (%)	σ	Dev. (%)	Temp. (℃)	Test Date
2450MSL	2450	52.70	1.95	52.28	-0.80	1.89	-3.08	22.5	04/05/2023
5200MSL	5200	49.00	5.27	48.26	-1.51	5.21	-1.14	22.7	04/06/2023
5800MSL	5800	48.20	6.00	48.67	0.98	5.86	-2.33	22.6	04/07/2023

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 22 of 84

7. System Verification Procedures

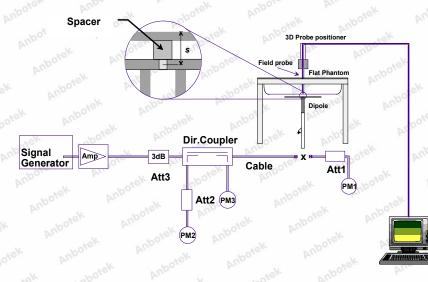
Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder.

Purpose of System Performance check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

System Setup

In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:



System Setup for System Evaluation

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Report No.: 18220WC30049301

FCC ID: 2ALU5G402TX Page 23 of 84



Photo of Dipole Setup

Validation Results

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10%. The table below shows the target SAR and measured SAR after normalized to 1W input power. It indicates that the system performance check can meet the variation criterion and the plots can be referred to Appendix A of this report.

Frequenc y (MHz)	Liquid Type	Power fed onto reference dipole (mW)	Targeted SAR (W/kg)	Measured SAR (W/kg)	Normalized SAR (W/kg)	Deviatio n (%)	Test Date
2450	Body	250	51.8	12.69	50.76	-2.01	04/05/2023
5200	Body	100	77.8	7.63	76.30	-1.93	04/06/2023
5800	Body	100 M	78.3	7.95	79.50	1.53	04/07/2023

Target and Measurement SAR after Normalized

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Code:AB-RF-05-b





Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 24 of 84

8. EUT Testing Position





(A) Horizontal-Up

(B) Horizontal-Down (C) Vertical-Front



(D) Vertical-Back

Note: These are USB connector orientations on laptop computers; USB dongles have the reverse configuration for plugging into the corresponding laptop computers.

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Code:AB-RF-05-b



Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 25 of 84

9. Measurement Procedures

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The measurement procedures are as follows:

- (a) Use base station simulator (if applicable) or engineering software to transmit RF power continuously (continuous Tx) in the middle channel.
- (b) Keep EUT to radiate maximum output power or 100% duty factor (if applicable)
- (c) Measure output power through RF cable and power meter.
- (d) Place the EUT in the positions as setup photos demonstrates.
- (e) Set scan area, grid size and other setting on the DASY software.
- (f) Measure SAR transmitting at the middle channel for all applicable exposure positions.
- (g) Identify the exposure position and device configuration resulting the highest SAR
- (h) Measure SAR at the lowest and highest channels at the worst exposure position and device configuration if applicable.

According to the test standard, the recommended procedure for assessing the peak spatial-average SAR value consists of the following steps:

- (a) Power reference measurement
- (b) Area scan
- (c) Zoom scan
- (d) Power drift measurement

9.1 Spatial Peak SAR Evaluation

The procedure for spatial peak SAR evaluation has been implemented according to the test standard. It can be conducted for 1g and 10g, as well as for user-specific masses. The DASY software includes all numerical procedures necessary to evaluate the spatial peak SAR value.

The base for the evaluation is a "cube" measurement. The measured volume must include the 1g and 10g cubes with the highest averaged SAR values. For that purpose, the center of the measured volume is aligned to the interpolated peak SAR value of a previously performed area scan.

The entire evaluation of the spatial peak values is performed within the post-processing engine (SEMCAD). The system always gives the maximum values for the 1g and 10g cubes. The algorithm to find the cube with highest averaged SAR is divided into the following stages:

- (a) Extraction of the measured data (grid and values) from the Zoom Scan
- (b) Calculation of the SAR value at every measurement point based on all stored data (A/D values and measurement parameters)
- (c) Generation of a high-resolution mesh within the measured volume
- (d) Interpolation of all measured values form the measurement grid to the high-resolution grid

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Code:AB-RF-05-b



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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 26 of 84

- (e) Extrapolation of the entire 3-D field distribution to the phantom surface over the distance from sensor to surface
- Calculation of the averaged SAR within masses of 1g and 10g (f)

9.2 Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

9.3 Area Scan Procedures

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB0 is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

Area scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

		1.3.V
	\leq 3 GHz	> 3 GHz
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	5 ± 1 mm	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
Maximum probe angle from probe axis to phantom surface normal at the measurement location	$30^{\circ}\pm1^{\circ}$	$20^{\circ} \pm 1^{\circ}$
	\leq 2 GHz: \leq 15 mm 2 - 3 GHz: \leq 12 mm	$3 - 4 \text{ GHz:} \le 12 \text{ mm}$ $4 - 6 \text{ GHz:} \le 10 \text{ mm}$
Maximum area scan spatial resolution: Δx_{Area} , Δy_{Area}	When the x or y dimension o measurement plane orientation the measurement resolution r	on, is smaller than the above,

x or y dimension of the test device with at least one measurement point on the test device.

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Code:AB-RF-05-b



Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 27 of 84

9.4Zoom Scan Procedures

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label. Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

			\leq 3 GHz	> 3 GHz
hoter Ann		riek rupo,	prin ak noter	AND
Maximum zoom scan s	spatial reso	olution: Δx_{700m} , ΔV_{700m}	$\leq 2 \text{ GHz}: \leq 8 \text{ mm}$	$3 - 4 \text{ GHz} \le 5 \text{ mm}^*$
		20011/ 9 20011	$2 - 3$ GHz: ≤ 5 mm ²	$4 - 6 \text{ GHz} \le 4 \text{ mm}^2$
				$3 - 4$ GHz: ≤ 4 mm
	uniform	grid: $\Delta z_{Zoom}(n)$	$\leq 5 \text{ mm}$	$4 - 5$ GHz: ≤ 3 mm
		100 Accession		$5 - 6 \text{ GHz}: \le 2 \text{ mm}$
Maximum zoom scan	ition,	$\Delta z_{Zoom}(1)$: between		$3 - 4$ GHz: ≤ 3 mm
spatial resolution,		1 st two points closest	\leq 4 mm	$4-5$ GHz: ≤ 2.5 mm
normal to phantom surface		to phantom surface		$5 - 6$ GHz: ≤ 2 mm
surface	grid	∆z _{Zoom} (n>1): between subsequent points	$\leq 1.5 \cdot \Delta$	z _{Zoom} (n-1)
Minimum zoom scan				3 – 4 GHz: ≥ 28 mm
volume	х, у, z		\geq 30 mm	$4-5$ GHz: ≥ 25 mm
				$5 - 6 \text{ GHz} \ge 22 \text{ mm}$

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

* When zoom scan is required and the <u>reported</u> SAR from the area scan based 1-g SAR estimation procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

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Code:AB-RF-05-b



Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 28 of 84

9.5 Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregate SAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

9.6 Power Drift Monitoring

All SAR testing is under the EUT install full charged battery and transmit maximum output power. In DASY measurement software, the power reference measurement and power drift measurement procedures are used for monitoring the power drift of EUT during SAR test. Both these procedures measure the field at a specified reference position before and after the SAR testing. The software will calculate the field difference in dB. If the power drift more than 5%, the SAR will be retested.

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Code:AB-RF-05-b



Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 29 of 84

10. Conducted Power

<WIFI 5GHz Conducted Power>

Band 1

Antenna 1:

Test Mode	Channel	Average Power[dBm]	Tune-Up Limit(dBm)	Test Rate Data
Ant tek	5180	12.65	13.00	6M
11A	5200	12.49	13.00	6M
	5240	12.49	13.00	6M
otek Anboten	5180	12.30	12.50	MCS0
11N20	5200	12.16	12.50	MCS0
	5240	12.07	12.50	MCS0
Anbour Anitao hot	5190	12.04	12.50	MCS0
11N40	5230	12.11	12.50	MCS0
anboten An	5180	12.02	12.50	MCS0
11AC20	5200	11.93	12.50	MCS0
	5240	11.81	12.50	MCS0
nbon Ada Can motely	5190	12.91	13.00	MCS0
11AC40	5230	11.53	13.00	MCS0
11AC80	5210	11.95	12.00	MCS0

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Report No.: 18220WC30049301

FCC ID: 2ALU5G402TX Page 30 of 84

Antenna 2:	Ar	And	wotek	Anbor A
Test Mode	Channel	Average Power[dBm]	Tune-Up Limit(dBm)	Test Rate Data
K Anbor A	5180	12.33	12.50	6M
11A	5200	12.39	12.50	6M
	5240	12.41	12.50	6M M
nbotek nbotek	5180	12.15	12.50	MCS0
11N20	5200	12.20	12.50	MCS0
	5240	12.22	12.50	MCS0
Protein Ar	5190	11.91	12.00	MCS0
11N40	5230	11.85	12.00	MCS0
ek spotek	5180	11.20	11.50	MCS0
11AC20	5200	11.30	11.50	MCS0
	5240	11.25	11.50	MCS0
Anboten Anbo	5190	12.90	13.00	MCS0
11AC40	5230	11.38	13.00	MCS0
11AC80	5210	11.96	12.00	MCS0

Band 4

Antenna 1:

Test Mode	Channel	Average Power[dBm]	Tune-Up Limit(dBm)	Test Rate Data
Ann stek An	5745	12.75	13.00	6M
11A	5785	12.29	13.00	6M
	5825	12.34	13.00	6M
botek Anbote	5745	12.22	12.50	MCS0
11N20	5785	11.89	12.50	MCS0
	5825	11.75	12.50	MCS0
Ambo	5755	12.09	12.50	MCS0
11N40	5795	11.91	12.50	MCS0
otek Anbore	5745	11.09	12.00	MCS0
11AC20	5785	11.01	12.00	MCS0
	5825	10.85	12.00	MCS0
Anos Add Can abore	5755	12.73	13.00	MCS0
11AC40	5795	11.01	13.00	MCS0
11AC80	5775	11.31	11.50	MCS0

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Test Mode	Channel	Average Power[dBm]	Tune-Up Limit(dBm)	Test Rate Data
And	5745	11.66	12.00	6M
11A	5785	11.51	12.00	6M
	5825	11.50	12.00	6M
wotek Anbotek	5745	12.21	12.50	MCS0
11N20	5785	11.94	12.50	MCS0
	5825	11.84	12.50	MCS0
Anbore An	5755	12.28	12.50	MCS0
11N40	5795	12.05	12.50	MCS0
tek unbotek p	5745	11.16	12.00	MCS0
11AC20	5785	10.88	12.00	MCS0
	5825	10.81	12.00	MCS0
Anboile AAACAO sofel	5755	12.73	13.00	MCS0
11AC40	5795	10.96	13.00	MCS0
11AC80	5775	11.20	11.50	MCS0

Note:

1. Per KDB 447498 D02 v02r01, the test distance less than 5mm

2. Per KDB 248227 D01, choose the highest output power channel to test SAR and determine further SAR exclusion.

3. Per KDB 248227 D01, In the 5 GHz band, separate SAR procedures are applied to DSSS and OFDM configurations to simplify DSSS test requirements. SAR is not required for the following 5 GHz OFDM conditions:

1) When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.

2) When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is \leq 1.2 W/kg.

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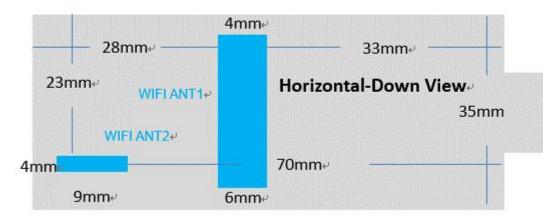
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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 32 of 84

11. Antenna Location

Vertical-Back View.



Vertical-Front View.

According to KDB 447498 D02, Horizontal-Up, Horizontal-Down, Vertical-Front, and Vertical-Back are tested.

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402T 'age 33 OT

SAR Test Results Summary 12.

General Note:

1. Per KDB 447498 D01 v06, the reported SAR is the measured SAR value adjusted for maximum tune-up tolerance.

Scaling Factor = tune-up limit power (mW) / EUT RF power (mW), where tune-up limit is the maximum rated power among all production units.

Reported SAR(W/kg)= Measured SAR(W/kg)* Scaling Factor Per KDB 447498 D01 v06, for each exposure position, if the highest output channel reported 2. SAR≤0.8W/kg, other channels SAR testing are not necessary

<WIFI 5GHz>

Plot No.	Band	Mode	Test Position	Gap (cm)	Ch.	Freq. (MHz)		Tune-U p Limit (dBm)	Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reporte d SAR _{1g} (W/kg)
#1	WIFI 5.2GHz	802.11 AC(HT40)	Horizontal- Down	0	38	5190	12.91	13.00	1.021	0.04	0.371	0.379
nborb	WIFI 5.2GHz	802.11 AC(HT40)	Horizontal- Up	nb Osk	38	5190	12.91	13.00	1.021	0.11	0.298	0.304
P	WIFI 5.2GHz	802.11 AC(HT40)	Vertical-Fr ont	Obot	38	5190	12.91	13.00	1.021	0.07	0.264	0.270
dek.	WIFI 5.2GHz	802.11 AC(HT40)	Vertical-Ba ck	0	38	5190	12.91	13.00	1.021	0.06	0.079	0.081
#2	WIFI 5.2GHz	802.11 AC(HT40)	Horizontal- Down	1000×	38	5190	12.90	13.00	1.023	0.13	0.339	0.347
An	WIFI 5.2GHz	802.11 AC(HT40)	Horizontal- Up	NO ^{ote}	38	5190	12.90	13.00	1.023	0.07	0.298	0.305
lek.	WIFI 5.2GHz	802.11 AC(HT40)	Vertical-Fr ont	0	38	5190	12.90	13.00	1.023	-0.08	0.237	0.243
botek	WIFI 5.2GHz	802.11 AC(HT40)	Vertical-Ba ck	0 boter	38	5190	12.90	13.00	1.023	-0.12	0.065	0.067

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 34 of 84

Plot No.	Band	Mode	Test Position	Gap (cm)	Ch.	Freq. (MHz)	Averag e Power (dBm)	Tune-U p Limit (dBm)	Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reporte d SAR _{1g} (W/kg)
#3	WIFI 5.8GHz	802.11A	Horizontal -Down	0 poten	149	5745	12.75	13.00	1.059	0.08	0.395	0.418
Anbo	WIFI 5.8GHz	802.11A	Horizontal -Up	AnOnek	149	5745	12.75	13.00	1.059	0.05	0.343	0.363
×	WIFI 5.8GHz	802.11A	Vertical-Fr ont	0 Anbu	149	5745	12.75	13.00	1.059	-0.11	0.289	0.306
otek	WIFI 5.8GHz	802.11A	Vertical-B ack	0 otek	149	5745	12.75	13.00	1.059	-0.07	0.097	0.103
#4	WIFI 5.8GHz	802.11 AC(HT40)	Horizontal -Down	unb0rek	151	5755	12.73	13.00	1.064	0.12	0.417	0.444
P	WIFI 5.8GHz	802.11 AC(HT40)	Horizontal -Up	O	151	5755	12.73	13.00	1.064	0.07	0.381	0.405
otek	WIFI 5.8GHz	802.11 AC(HT40)	Vertical-Fr ont	0	151	5755	12.73	13.00	1.064	-0.08	0.318	0.338
nboter	WIFI 5.8GHz	802.11 AC(HT40)	Vertical-B ack	nbolek	151	5755	12.73	13.00	1.064	-0.03	0.107	0.114

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 35 of 84

13. Simultaneous Transmission Analysis

Simultaneous TX SAR Considerations

- No. Applicable Simultaneous Transmission
- 1. WIFI 5.2G ANT1 +WIFI 5.2G ANT2
- 2. WIFI 5.8G ANT1 +WIFI 5.8G ANT2

WIFI 5.2G ANT1 +WIFI 5.2G ANT2:

		14/101	- 2.S			
Test Position	WiFi WiFi ANT 1 ANT 2 SAR _{1-g} SAR _{1-g} (W/Kg) (W/Kg)		MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required	
Horizontal- Down	0.379	0.347	0.726	1.6 And	N/A Moote	
Horizontal- Up	0.304	0.305	0.609	1.6	N/A	
Vertical-Fro nt	0.270	0.243	0.513	1.6	N/A	
Vertical-Ba ck	0.081	0.067	0.148	1.6 Anbot	N/A	

WIFI 5.8G ANT1 +WIFI 5.8G ANT2:

Test Position	WiFi WiFi ANT 1 ANT 2 SAR _{1-g} SAR ₁₋ (W/Kg) (W/Kg		MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required		
Horizontal- Down	0.418	0.444	0.862	1.6	nbote ^k N/A Anbo		
Horizontal- Up	0.363	0.405	0.768	1.6	N/A		
Vertical-Fro nt	0.306	0.338	0.644	1.6	N/A		
Vertical-Ba ck	0.103	0.114	0.217	^{1.6}	botek N/A Anbol		

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Code:AB-RF-05-b



 Report No.: 18220WC30049301
 FCC ID: 2ALU5G402TX
 Page 36 of 84

14. Measurement Uncertainty

	bore An	rer	and a		1	-de	bolo	PIL	
NO	Source	Uncert. ai (%)	Prob. Dist.	Div. k	ci (1g)	ci (10g)	Stand.U ncert. ui (1g)	Stand.U ncert. ui (10g)	Veff
nborol	Ambo, M.	yek p	nbote	Par	-Yek	Anbe	ui (ig)	ui (iog)	hote
1.10	Repeat	0.4	Anbotek	1 ^{Anl}	°` 1×	1	0.4	0.4	9
bu.	nbotek Anboten A	notek	Instru		ANDO	ek A	Anbotek	Anborer	N PUD
- V	botek Anbote	Ant		NOV.	Pupo	-ot	h. botek	Anborn	P
2	Probe calibration	17 ^{ibotel}	N	2	20	pote 1	3.5	3.5	o ^{tek} ∞
	Anbo wet shotek		No Al	. de	×.	Anboten	Anbo	-ak	
3 ek	Axial isotropy	4.7	Noote R	Anbote	0.7	0.7	^{ek} 1.9 M	1.9	Anborel
	Axiai isotropy		abotek	√3	010	Pur	otek	Anboten	
buo.	tek spotek A	1001	pli wotek	1	nboten	b.	, vek	abotek	Aup
4 🕅	Hemispherical isotropy	9.4	R	√3	0.7	0.7	3.9	3.9	∞ ⊳
	Anbote, And	Anbotek	Anbo	alt.	P*	Jorek.	Anbore	An	Note.
65	Boundary effect	1.0 Anbo	e ^{sk} R pri	√3	1	Anboltek	0.6	0.6	nbotel®
botek	Anboy An hot	ek Ar	loote.	Pur	494	Anbot	sk Ant		hotek
6	Linearity	4.7	R	√3	1	1	2.7	2.7	00
Par	otek unbotek Ar	pu	botek	P	upote	he be	-otek	Anboreh	Aup.
7 0	Detection limits	1.0	R	√3	Antopte	1	0.6	0.6	00
	Anbo	NUpote.	PUD	. ex-	1.2	0,61	Aupor		,tek
8	Readout electronics	0.3	ek N Ant	°`1	M	1.K	0.3	0.3	∞
	unbotek Anbo		otek	Anboter	P	in-	K anb	otek A	
9	Response time	0.8	R	√3	rek 1	ATOOTE	0.5	0.5	8
Anboth	An sotek an		Anbo		Votek,	Ant	jore p	un	
10	Integration time	2.6	AR	√3	1,01	1	1.5	1.5	∞
	abotek Anbo	hotek	Anbote		Aun	*ek	abotek	Pupo.	ek pr
11	Ambient noise	3.0	R	√3	P1bc	1	1.7	1.7,000	∞
	prot otek nobotek	Pupo.	dek .	abotek	P	upore.	Plan	yek No	botek
12	Ambient reflections	3.0 M	R	√3	e ^x 1	Antpote	1.7 ^{Anbr}	1.7	00
nbote	Probe positioner mech.	otek	aboter	PUD	.vek	Anb	Net P	1,00,	P.1.
13	restrictions	0.4	R	√3	001- 1.4	1	0.2	0.2	00
Ano	restrictions	unborek	Anbotel	10	anboten	P	nb ^{or} 0.2	Anbotek	Ant

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Report	No.: 18220WC3004	9301	FC	C ID:	2ALL	J5G40	2TX	Page	37 of 84
nboten	Probe positioning with	K Ant		Anbot		Anbote	tek And	nbotek	Anbotek
14	respect to phantom shell	2.9	Anborek	√3	o ^{otek} 1	1 ^{Anb}	1.7	Am 1.7	N∞015
15	Max.SAR evaluation	1.0 pore	Anbo	√3	Anbo	rek notak	0.6	0.6	ox ∞

And	otek Anbotek Anb	nbotek	Test samp	ole rel	ated	Ano	nbotek	Anbotek	Anbor
16	Device positioning	3.8	Anbore N _{Anbo}	¹⁰	Ann Mupo	ek otel	3.8	3.8	99
17	Device holder	5.1pmb	N A	hoter 1	р. к. 1	Anthetek	5.1	5.1	unbotelt 5
18	Drift of output power	5.0	Anbotek R	√3	otek	Anbo 1 Ar	2.9	2.9	∞
P	nboten Anbotek	Anbotek	Phantom a	and se	et-up	ek	Anboten	And	K Ant
19	Phantom uncertainty	4.0	R M	√3	1 An	potek obliek	2.3	2.3	over w
20	Liquid conductivity (target)	5.0	hotek AnboRk	√3	0.64	0.43	1.8	1.2	× ×
21	Liquid conductivity (meas)	2.5	Anbotek N Anbote	M 1	0.64	0.43	1.6	1.2	on p ∩b
22	Liquid Permittivity (target)	5.0	ak Ant	√3	0.6	0.49	1.7	otel 1.5	and the second
23	Liquid Permittivity (meas)	2.5	Anbotek N	Anbo 1	0.6	0.49	1.5	1.2	Anboie Anboie
An	Combined standard	Anbotek	Anbote	Note U	$c = \sqrt{\sum_{i=1}^{n}}$	$C_i^2 U_i^2$	Anbotek	Anbotek	tek A
lek tek		Anboth	RSS	nbotek	V 1=1		11.4%	11.3%	236
unc	Expanded ertainty(P=95%)	otek	Anbotek L	J=ku	/ ,k=:	2 Anbor	22.8%	22.6%	Anboten

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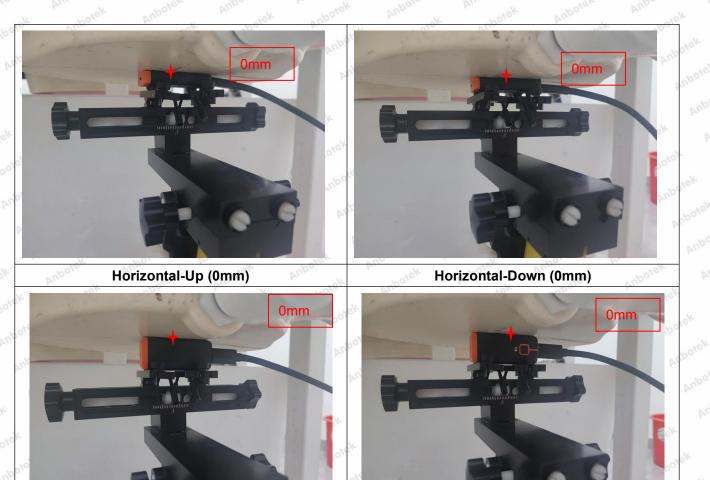
Hotline





Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 38 of 84

Appendix A. EUT Photos and Test Setup Photos



Vertical-Front (0mm)

Vertical-Back (0mm)

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Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 39 of 84

Appendix B. Plots of SAR System Check

Date:04/06/2023

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN:1160 Communication System: UID 0, CW; Frequency: 5200 MHz; Duty Cycle: 1:1 Medium parameters used: f = 5200 MHz; σ = 5.21 S/m; ϵ_r = 48.26; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

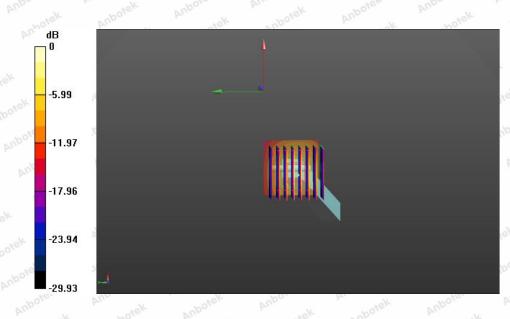
5200MHz Body System Check

- Probe: EX3DV4 SN7396; ConvF(4.93, 4.93, 4.93); Calibrated: May 06, 2022;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2022
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=100mW/Area Scan (71x71x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Maximum value of SAR (interpolated) = 20.9 W/kg

Configuration/Pin=100mW/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm

Reference Value = 59.857 V/m; Power Drift = 0.04 dB Peak SAR (extrapolated) = 34.58 W/kg SAR(1 g) = 7.63 W/kg; SAR(10 g) = 2.21 W/kg Maximum value of SAR (measured) = 20.8 W/kg



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Report No.: 18220WC30049301

FCC ID: 2ALU5G402TX Page 40 of 84

Date:04/07/2023

5800MHz Body System Check

DUT: Dipole 5800 MHz; Type: D5GHzV2; Serial: D5GHzV2 - SN:1160 Communication System: UID 0, CW; Frequency: 5800 MHz;Duty Cycle: 1:1 Medium parameters used: f = 5800 MHz; σ = 5.86 S/m; ϵ_r = 48.67; ρ = 1000 kg/m³

Phantom section: Flat Section

DASY5 Configuration:

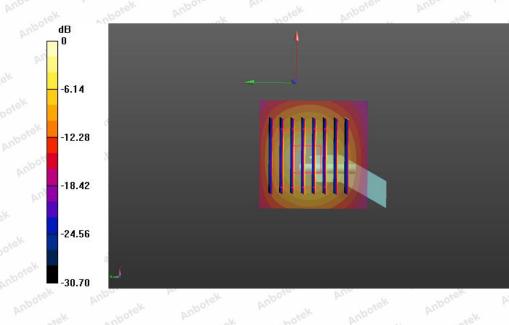
- Probe: EX3DV4 SN7396; ConvF(4.52, 4.52, 4.52); Calibrated: May 06, 2022;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2022
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=100mW/Area Scan (71x71x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Maximum value of SAR (interpolated) = 18.8 W/kg

Configuration/Pin=100mW/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm,

dz=1.4mm

Reference Value = 56.773 V/m; Power Drift = 0.08 dB Peak SAR (extrapolated) = 31.5 W/kg SAR(1 g) = 7.95 W/kg; SAR(10 g) = 2.23 W/kg Maximum value of SAR (measured) = 19.8 W/kg



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Code:AB-RF-05-b





Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 41 of 84

Appendix C. Plots of SAR Test Data

#1

Date: 04/06/2023

WIFI 5.2G_802.11AC(HT40)_CH38 Horizontal-Down

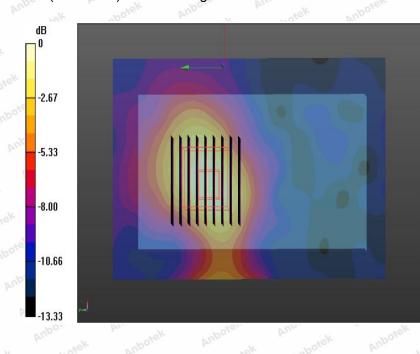
Communication System: UID 0, wifi (fcc) (0); Frequency: 5190 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5190 MHz; σ = 5.21 S/m; ϵ_r = 48.26; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.93, 4.93, 4.93); Calibrated: May 06, 2022;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2022;
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Horizontal-Down /Area Scan (101x111x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (interpolated) = 0.935 W/kg

Horizontal-Down /Zoom Scan (8x8x8)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 6.942 V/m; Power Drift = 0.04 dB Peak SAR (extrapolated) = 0.982 W/kg SAR(1 g) = 0.371 W/kg; SAR(10 g) = 0.215 W/kg Maximum value of SAR (measured) = 0.927 W/kg



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Code:AB-RF-05-b





Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 42 of 84 #2 Date: 04/06/2023

WIFI 5.2G_802.11AC(HT40)_CH38 Horizontal-Down

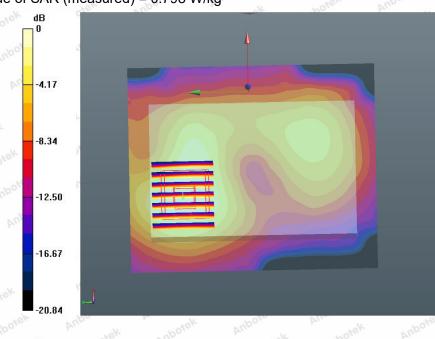
Communication System: UID 0, wifi (fcc) (0); Frequency: 5190 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5190 MHz; σ = 5.21 S/m; ϵ_r = 48.26; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.93, 4.93, 4.93); Calibrated: May 06, 2022;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2022;
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Horizontal-Down /Area Scan (101x121x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (interpolated) = 0.787 W/kg

Horizontal-Down /Zoom Scan (8x8x8)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 6.164 V/m; Power Drift = 0.13 dB Peak SAR (extrapolated) = 0.880 W/kg SAR(1 g) = 0.339 W/kg; SAR(10 g) = 0.186 W/kg Maximum value of SAR (measured) = 0.798 W/kg



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Code:AB-RF-05-b



Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 43 of 84

#3

Date: 04/07/2023

WIFI 5.8G_802.11A_CH149 Horizontal-Down

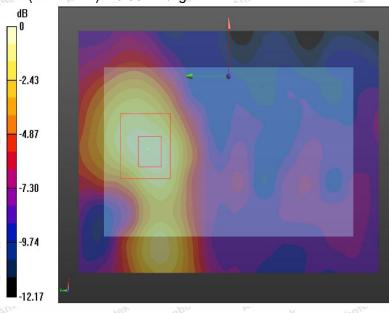
Communication System: UID 0, wifi (fcc) (0); Frequency: 5745 MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5745 MHz; σ = 5.86 S/m; ϵ_r = 48.67; ρ = 1000 kg/m3 Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.52, 4.52, 4.52); Calibrated: May 06, 2022;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2022
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Horizontal-Down /Area Scan (101x111x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (measured) = 0.837 W/kg

Horizontal-Down /Zoom Scan (8x8x8)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 5.334 V/m; Power Drift = 0.08 dB Peak SAR (extrapolated) = 0.917 W/kg SAR(1 g) = 0.395 W/kg; SAR(10 g) = 0.216 W/kg Maximum value of SAR (measured) = 0.831 W/kg



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Code:AB-RF-05-b



Report No.: 18220WC30049301 FCC ID: 2ALU5G402TX Page 44 of 84

#4

Date: 04/07/2023

WIFI 5.8G_802.11AC(HT40)_CH151 Horizontal-Down

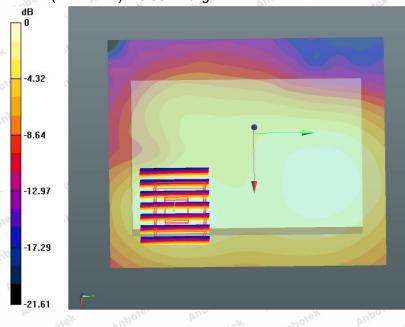
Communication System: UID 0, wifi (fcc) (0); Frequency: 5751 MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5751 MHz; σ = 5.86 S/m; ϵ_r = 48.67; ρ = 1000 kg/m3 Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.52, 4.52, 4.52); Calibrated: May 06, 2022;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2022
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Horizontal-Down /Area Scan (101x121x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (measured) = 0.913 W/kg

Horizontal-Down /Zoom Scan (8x8x8)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 7.285 V/m; Power Drift = 0.12 dB Peak SAR (extrapolated) = 0.957 W/kg SAR(1 g) = 0.417 W/kg; SAR(10 g) = 0.201 W/kg Maximum value of SAR (measured) = 0.902 W/kg

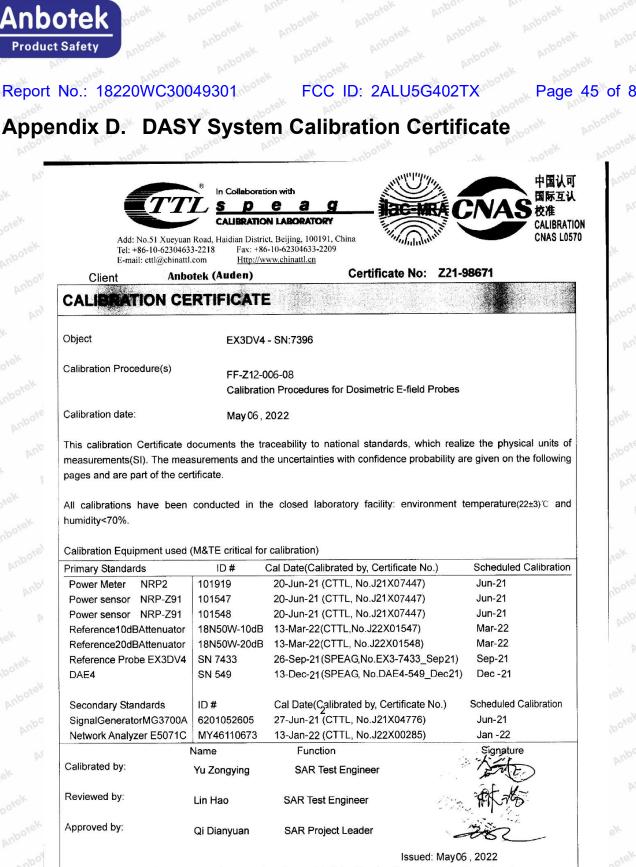


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Code:AB-RF-05-b





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Page 1 of 11

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Report No.: 18220WC30049301



Page 46 of 84



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Glossary:

oloodaly.	
TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConvF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i
	A=0 is normal to probe axis

g

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz" Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ=0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E^2 -field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z* frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx, y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax,y,z; Bx,y,z; Cx,y,z; VRx,y,z:A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: Z21-98671

Page 2 of 11

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Code:AB-RF-05-b





FCC ID: 2ALU5G402TX Page 47



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Probe EX3DV4

SN: 7396

Calibrated: May 06, 2022

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: Z21-98671

Page 3 of 11

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of 84



FCC ID: 2ALU5G402TX Page 48 of 84



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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm(µV/(V/m) ²) ^A	0.54	0.53	0.50	±10.0%
DCP(mV) ^B	97.8	104.5	102.5	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	C	D dB	VR mV	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	199.9	±2.4%
		Y	0.0	0.0	1.0		203.3	
		Z	0.0	0.0	1.0		195.0	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5 and Page 6). ^B Numerical linearization parameter: uncertainty not required.

^E Uncertainly is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Certificate No: Z21-98671

Page 4 of 11

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FCC ID: 2ALU5G402TX Page 49 of 84



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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) [⊦]	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	41.9	0.89	9.82	9.82	9.82	0.30	0.85	±12.1%
835	41.5	0.90	9.71	9.71	9.71	0.15	1.36	±12.1%
900	41.5	0.97	9.87	9.87	9.87	0.16	1.37	±12.1%
1750	40.1	1.37	8.61	8.61	8.61	0.25	1.04	±12.1%
1900	40.0	1.40	8.13	8.13	8.13	0.24	1.01	±12.1%
2100	39.8	1.49	8.14	8.14	8.14	0.24	1.04	±12.1%
2300	39.5	1.67	7.85	7.85	7.85	0.40	0.75	±12.1%
2450	39.2	1.80	7.57	7.57	7.57	0.50	0.75	±12.1%
2600	39.0	1.96	7.38	7.38	7.38	0.64	0.68	±12.1%
5250	35.9	4.71	5.33	5.33	5.33	0.45	1.30	±13.3%
5600	35.5	5.07	4.89	4.89	4.89	0.45	1.35	±13.3%
5750	35.4	5.22	4.92	4.92	4.92	0.45	1.45	±13.3%

^c Frequency validity above 300 MHz of \pm 100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to \pm 50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is \pm 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to \pm 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters. ^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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Page 5 of 11

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Code:AB-RF-05-b





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Page 50 of 84



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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) [⊦]	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	55.5	0.96	10.09	10.09	10.09	0.30	0.90	±12.1%
835	55.2	0.97	9.88	9.88	9.88	0.19	1.32	±12.1%
900	55.0	1.05	9.82	9.82	9.82	0.23	1.15	±12.1%
1750	53.4	1.49	8.24	8.24	8.24	0.24	1.06	±12.1%
1900	53.3	1.52	7.97	7.97	7.97	0.19	1.24	±12.1%
2100	53.2	1.62	8.18	8.18	8.18	0.19	1.39	±12.1%
2300	52.9	1.81	7.88	7.88	7.88	0.55	0.80	±12.1%
2450	52.7	1.95	7.53	7.53	7.53	0.46	0.89	±12.1%
2600	52.5	2.16	7.38	7.38	7.38	0.52	0.80	±12.1%
5250	48.9	5.36	4.93	4.93	4.93	0.45	1.80	±13.3%
5600	48.5	5.77	4.19	4.19	4.19	0.48	1.90	±13.3%
5750	48.3	5.94	4.52	4.52	4.52	0.48	1.95	±13.3%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

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Page 6 of 11

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